

Search Notes

Application/Control No.

10/519,854

Examiner

Hae M. Hyeon

Applicant(s)/Patent under
Reexamination

CLAUS ET AL.

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
439	178	11/05	hm h
439	179		
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439	425		
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174	21R		

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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